

Notice of References Cited	Application/Control No. 10/723,833		Applicant(s)/Patent Under Reexamination HATSCH ET AL.	
	Examiner Michael t. Tran		Art Unit 2827	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0213027	10-2004	Liu et al.	365/049
*	B	US-6,286,091	09-2001	Park, Sung Soo	711/207
*	C	US-6,215,685	04-2001	Fung et al.	365/49
*	D	US-6,199,140	03-2001	Srinivasan et al.	711/108
*	E	US-6,944,709	09-2005	Nataraj et al.	711/108
*	F	US-6,421,265	07-2002	Lien et al.	365/49
*	G	US-6,000,008	12-1999	Simcoe, Robert J.	711/108
*	H	US-2001/0017801	08-2001	Helwig et al.	365/201
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.